

Notice of References Cited

Application/Control No.

10/572,527

Applicant(s)/Patent Under

Reexamination

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Examiner

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Art Unit

2615

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,239,945	12-1980	Atoji et al.	381/371
	B	US-			
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	D	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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